

# AUIRF1010Z AUIRF1010ZS AUIRF1010ZL

Source

# Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

# Description

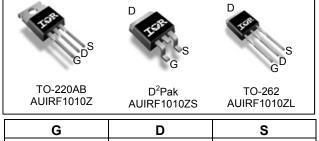
Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

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Gate

# HEXFET<sup>®</sup> Power MOSFET V<sub>DSS</sub> 55V R<sub>DS(on)</sub> max. 7.5mΩ

R <sub>DS(on)</sub> max.	7.5mΩ
D (Silicon Limited)	94A
D (Package Limited)	75A



Drain

Bass part number	Standard Package Type			Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRF1010Z	TO-220	Tube	50	AUIRF1010Z
AUIRF1010ZL	TO-262	Tube	50	AUIRF1010ZL
	D <sup>2</sup> -Pak	Tube	50	AUIRF1010ZS
AUIRF1010ZS	D -Pak	Tape and Reel Left	800	AUIRF1010ZSTRL

### Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	94	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	66	
l <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	75	A
I <sub>DM</sub>	Pulsed Drain Current ①	360	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	140	W
	Linear Derating Factor	0.90	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 2	130	
E <sub>AS</sub> (tested)	Single Pulse Avalanche Energy Tested Value 6	180	mJ
AR	Avalanche Current ①	See Fig.15,16, 12a, 12b	A
E <sub>AR</sub>	Repetitive Avalanche Energy		mJ
TJ	Operating Junction and	-55 to + 175	
Г <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw®	10 lbf•in (1.1N•m)	

### Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case		1.11	
$R_{ ext{ heta}CS}$	Case-to-Sink, Flat, Greased Surface 🛛	0.50		°C/W
$R_{ ext{ heta}JA}$	Junction-to-Ambient		62	C/W
$R_{ heta JA}$	Junction-to-Ambient (PCB Mount, steady state) ®		40	

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\*Qualification standards can be found at www.infineon.com



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	55			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.049		V/°C	Reference to $25^{\circ}$ C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		5.8	7.5	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 75A ③
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μΑ
gfs	Forward Trans conductance	33				V <sub>DS</sub> = 25V, I <sub>D</sub> = 75A
	Drain-to-Source Leakage Current			20		V <sub>DS</sub> = 55 V, V <sub>GS</sub> = 0V
IDSS	Diam-10-Source Leakage Current			250	μA	V <sub>DS</sub> = 55V,V <sub>GS</sub> = 0V,T <sub>J</sub> =125°C
	Gate-to-Source Forward Leakage			200	5	V <sub>GS</sub> = 20V
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-200	nA	V <sub>GS</sub> = -20V

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Devenueter	N.4.:	T. m	Max	L Incide	Canditiana
cteristics					
Effective Output Capacitance		560			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 44V \oplus$
Output Capacitance		360			$V_{GS} = 0V, V_{DS} = 44V f = 1.0MHz$
Output Capacitance		1630		μr	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
Reverse Transfer Capacitance		250		pF	<i>f</i> = 1.0MHz, See Fig. 5
Output Capacitance		420			V <sub>DS</sub> = 25V
Input Capacitance		2840			V <sub>GS</sub> = 0V
Internal Source Inductance		7.5		nH	from package and center of die contact
Internal Drain Inductance		4.5		ъЦ	Between lead, 6mm (0.25in.)
Fall Time		92			V <sub>GS</sub> = 10V ③
Turn-Off Delay Time		36		115	R <sub>G</sub> = 6.8Ω
Rise Time		150		ns	I <sub>D</sub> = 75A
Turn-On Delay Time		18			$V_{DD} = 28V$
Gate-to-Drain Charge		24			V <sub>GS</sub> = 10V③
Gate-to-Source Charge		19		nC	$V_{DS} = 44V$
Total Gate Charge		63	95		I <sub>D</sub> = 75A
Gate	e-to-Source Charge	e-to-Source Charge —	e-to-Source Charge — 19	e-to-Source Charge — 19 —	e-to-Source Charge — 19 — nC

	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current (Body Diode)			75		MOSFET symbol
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			360	A	integral reverse
V <sub>SD</sub>	Diode Forward Voltage			1.3		$T_J = 25^{\circ}C_{,I_S} = 75A_{,V_{GS}} = 0V$ (3)
t <sub>rr</sub>	Reverse Recovery Time		22	33	ns	T <sub>J</sub> = 25°C ,I <sub>F</sub> = 75A, V <sub>DD</sub> = 25V
Q <sub>rr</sub>	Reverse Recovery Charge		15	23	nC	di/dt = 100A/µs ③
t <sub>on</sub>	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{s}+L_{D}$ )			

Notes:

 $\odot$  Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

② Limited by  $T_{Jmax}$ , starting  $T_J$  = 25°C, L = 0.05mH, R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 75Å, V<sub>GS</sub> =10V. Part not recommended for use above this value. ③ Pulse width ≤ 1.0ms; duty cycle ≤ 2%.

④ Coss eff. is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS.

 $\ensuremath{\mathbb{S}}$  Limited by  $T_{Jmax}$  , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

S This value determined from sample failure population, starting T<sub>J</sub> = 25°C, L = 0.05mH, R<sub>G</sub> = 25 $\Omega$ , I<sub>AS</sub> = 75A, V<sub>GS</sub> =10V.

⑦ This is only applied to TO-220AB package.

When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

 $\$  R<sub> $\theta$ </sub> is measured at T<sub>J</sub> approximately 90°C.



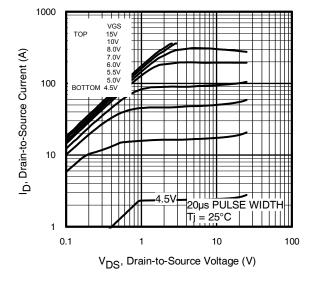


Fig. 1 Typical Output Characteristics

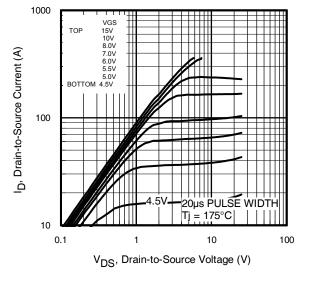


Fig. 2 Typical Output Characteristics

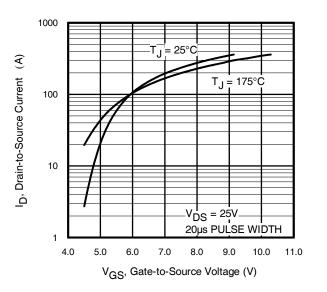


Fig. 3 Typical Transfer Characteristics

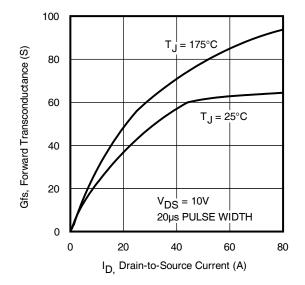
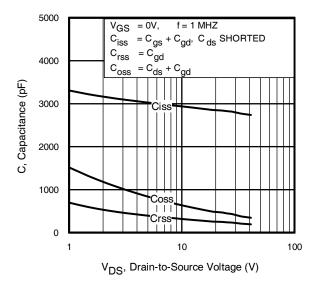
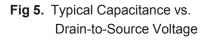


Fig. 4 Typical Forward Trans conductance vs. Drain Current







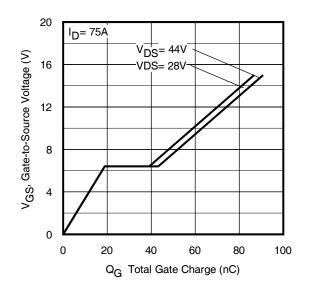


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

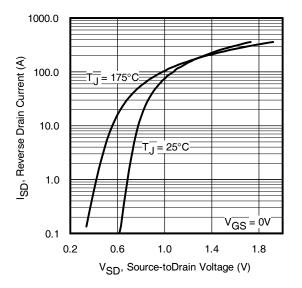


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

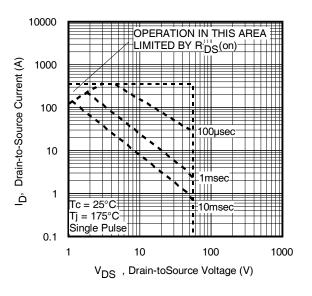
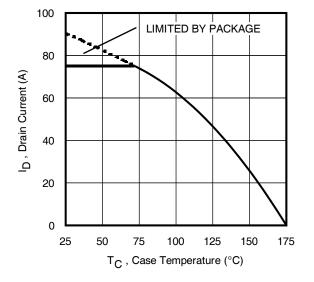


Fig 8. Maximum Safe Operating Area





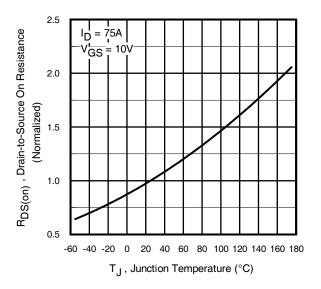


Fig 9. Maximum Drain Current vs. Case Temperature

Fig 10. Normalized On-Resistance vs. Temperature

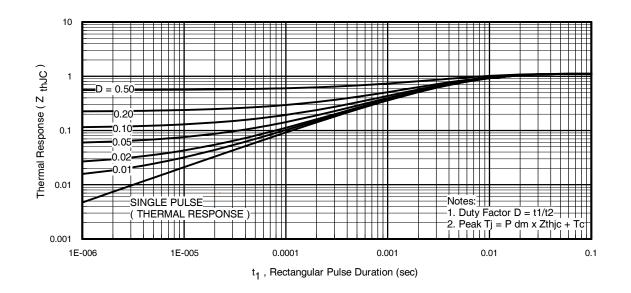


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

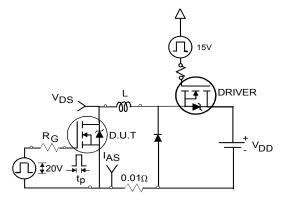


Fig 12a. Unclamped Inductive Test Circuit

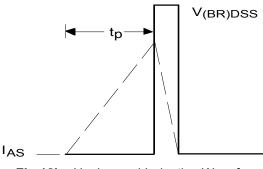
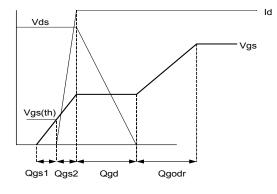
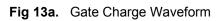


Fig 12b. Unclamped Inductive Waveforms





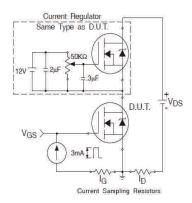
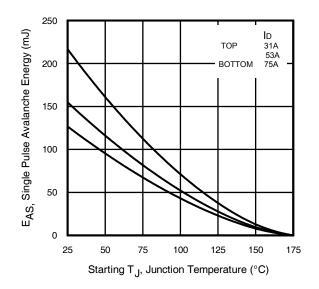
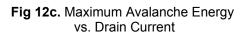


Fig 13b. Gate Charge Test Circuit





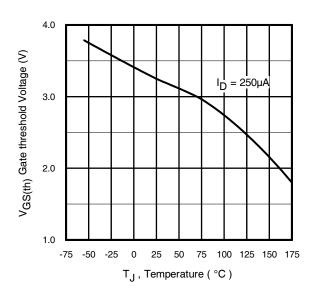


Fig 14. Threshold Voltage vs. Temperature

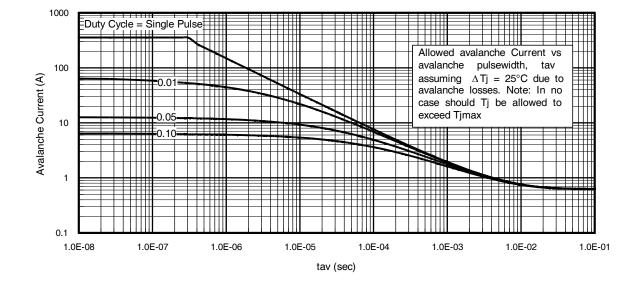
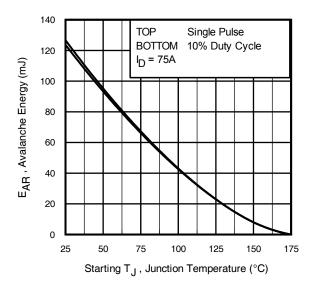
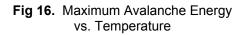


Fig 15. Typical Avalanche Current vs. Pulse width





#### Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4.  $P_{D (ave)}$  = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).
  - tav = Average time in avalanche.
  - D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} \textbf{P}_{D \;(ave)} &= 1/2 \; ( \; \textbf{1.3} \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T / \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2 \Delta T / \; [\textbf{1.3} \cdot \textbf{BV} \cdot \textbf{Z}_{th}] \\ \textbf{E}_{AS \;(AR)} &= \textbf{P}_{D \;(ave)} \cdot \textbf{t}_{av} \end{split}$$

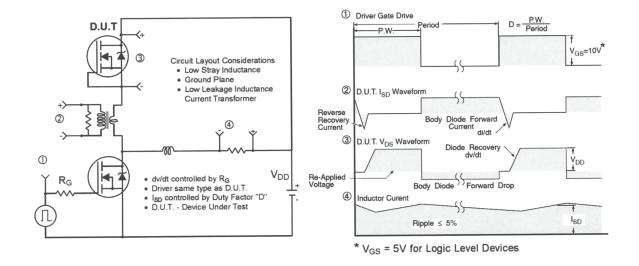


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

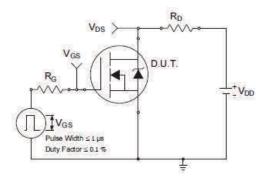


Fig 18a. Switching Time Test Circuit

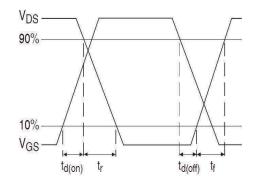
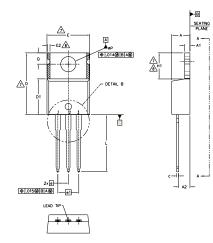
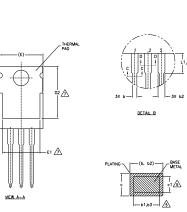


Fig 18b. Switching Time Waveforms



# TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





SECTION C-C & D-D

NOTES:	
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- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994. 1.-
- 2.-
- 3 -
- DIMENSIONING AND TOLERANGUNG AS FER ASME 114.5 MF 1994. DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS] LEAD DIMENSION AND FINISH UNCONTROLLED IN L1. DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE 4.-MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY. /5.-\
- 6.-CONTROLLING DIMENSION : INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1 7. – DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED. 8. –
- UTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE. 9 -

	DIMENSIONS					
SYMBOL	MILLIM	ETERS	INC	HES		
	Min.	MAX.	MIN.	MAX.	NOTES	
A	3.56	4.83	.140	.190		
A1	1.14	1.40	.045	.055		
A2	2.03	2.92	.080	.115		
b	0.38	1.01	.015	.040		
b1	0.38	0.97	.015	.038	5	
b2	1.14	1.78	.045	.070		
b3	1.14	1.73	.045	.068	5	
с	0.36	0.61	.014	.024		
c1	0.36	0.56	.014	.022	5	
D	14.22	16.51	.560	.650	4	
D1	8.38	9.02	.330	.355		
D2	11.68	12.88	.460	.507	7	
E	9.65	10.67	.380	.420	4,7	
E1	6.86	8.89	.270	.350	7	
E2	-	0.76	-	.030	8	
е	2.54 5.08	BSC	.100	.100 BSC		
e1	5.08	BSC	.200 BSC			
H1	5.84	6.86	.230	.270	7,8	
L	12.70	14.73	.500	.580		
L1	3.56	4.06	.140	.160	3	
ØP	3.54	4.08	.139	.161		
Q	2.54	3.42	.100	.135		

#### LEAD ASSIGNMENTS

<u>HEXFET</u> 1.- GATE 2.- DRAIN 3.- SOURCE

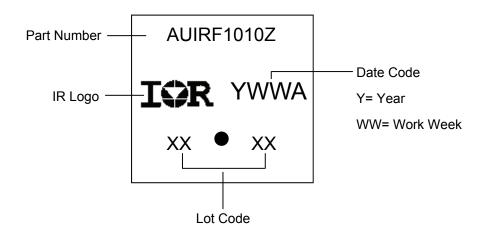
IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE 2.- CATHODE 3.- ANODE

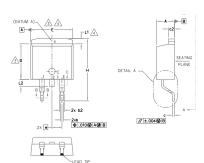
### **TO-220AB Part Marking Information**



TO-220AB package is not recommended for Surface Mount Application.



# D<sup>2</sup>Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994

2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

7. CONTROLLING DIMENSION: INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

	S Y M	DIMENSIONS					
E	S C	MILLIM	eters	IN	CHES		
	L	MIN.	MAX.	MIN.	MAX.	S	
A	4	4.06	4.83	.160	.190		
A	1	0.00	0.254	.000	.010		
ł	C	0.51	0.99	.020	.039		
b	51	0.51	0.89	.020	.035	5	
b	2	1.14	1.78	.045	.070		
b	3	1.14	1.73	.045	.068	5	
0	0	0.38	0.74	.015	.029		
0	:1	0.38	0.58	.015	.023	5	
С	2	1.14	1.65	.045	.065		
[	)	8.38	9.65	.330	.380	3	
C	)1	6.86	_	.270	_	4	
E	-	9.65	10.67	.380	.420	3,	
E	1	6.22	_	.245	—	4	
6	Э	2.54	BSC	.100	BSC		
ŀ	-	14.61	15.88	.575	.625		
1	_	1.78	2.79	.070	.110		
L	_1	_	1.68	—	.066	4	
L	2	_	1.78	-	.070		
L	3	0.25	BSC	.010	BSC	1	

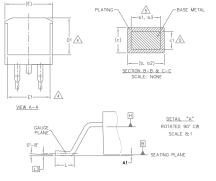
# LEAD ASSIGNMENTS

Date Code

WW= Work Week

Y= Year

DIODES 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE HEXFET IGBTs, CoPACK 1.- GATE 2, 4.- DRAIN 3.- SOURCE 1.- GATE 2, 4.- COLLECTOR 3.- EMITTER



D<sup>2</sup>Pak (TO-263AB) Part Marking Information

Part Number

IR Logo

13	0.25		010	DSC	-
L2	_	1.78	-	.070	
L1	_	1.68	-	.066	4
L	1.78	2.79	.070	.110	
Н	14.61	15.88	.575	.625	1
e	2.54	BSC	.100	BSC	1
E1	6.22	_	.245	_	4
E	9.65	10.67	.380	.420	3,4
D1	6.86	_	.270	_	4
D	8.38	9.65	.330	.380	3
c2	1.14	1.65	.045	.065	
с1	0.38	0.58	.015	.023	5
С	0.38	0.74	.015	.029	
b3	1.14	1.73	.045	.068	5
b2	1.14	1.78	.045	.070	
b1	0.51	0.89	.020	.035	5
D	0.51	0.99	.020	.039	

AUIRF1010ZS

Lot Code

**I** CR

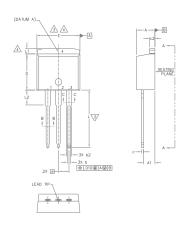
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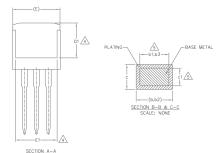
WWA

XX



# TO-262 Package Outline (Dimensions are shown in millimeters (inches)





#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 2.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

#### LEAD ASSIGNMENTS

IGBTS, COPACK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER
- 4.- COLLECTOR

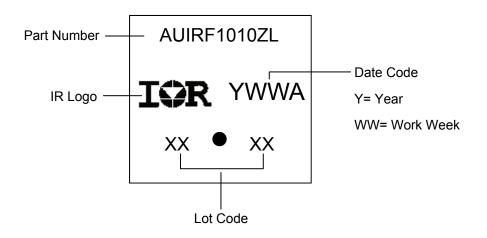
HEXFET DIODES

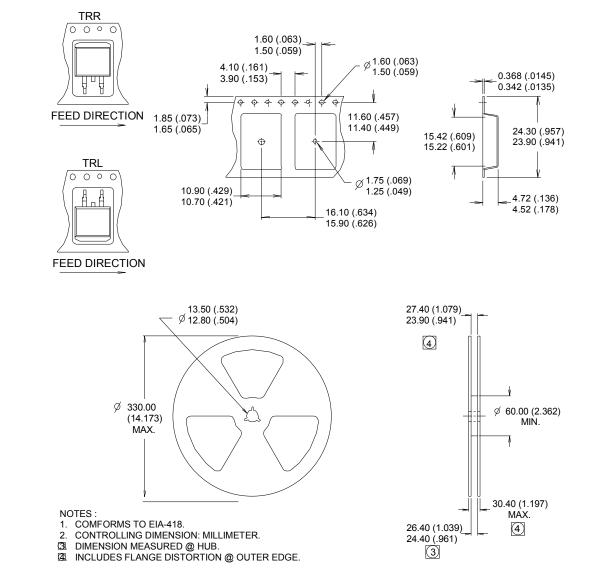
- 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN



DIMENSIONS N O T M B O MILLIMETERS INCHES MIN. MAX. MIN. MAX. 4.83 А 4.06 160 190 Α1 2.03 3.02 .119 .080. b 0.51 0.99 .039 b1 0.51 0.89 .035 5 1.78 1.14 .045 1,14 1.73 .045 068 5 b.3 0.38 0.74 С .015 .029 0.38 0.58 .023 5 c2 1.14 1.65 .045 .065 8.38 9.65 D .330 .380 3 D1 .270 6.86 4 Ε 9.65 10.67 .380 .420 3,4 E1 6.22 245 4 2.54 BSC BSC е 13.46 14.10 530 L1 1.65 065 4 3.56 3.71 L2 140 .146

#### **TO-262 Part Marking Information**





D<sup>2</sup>Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))



# **Qualification Information**

		Automotive (per AEC-Q101)	
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.	
Moisture Sensitivity Level		TO-220AB	N/A
		TO-262	MSL1
		D <sup>2</sup> -Pak	
ESD	Machine Model	Class M4 (+/- 700V) <sup>†</sup>	
		AEC-Q101-002	
	Human Body Model	Class H1C (+/-1500V) <sup>†</sup>	
		AEC-Q101-001	
	Charged Device Model	Class C5 (+/-2000V) <sup>†</sup>	
		AEC-Q101-005	
RoHS Compliant		Yes	

+ Highest passing voltage.

### **Revision History**

Date	Comments	
11/6//2015	<ul> <li>Updated datasheet with corporate template</li> <li>Corrected ordering table on page 1.</li> </ul>	
9/18/2017	Corrected typo error on part marking on page 9,10,11.	

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